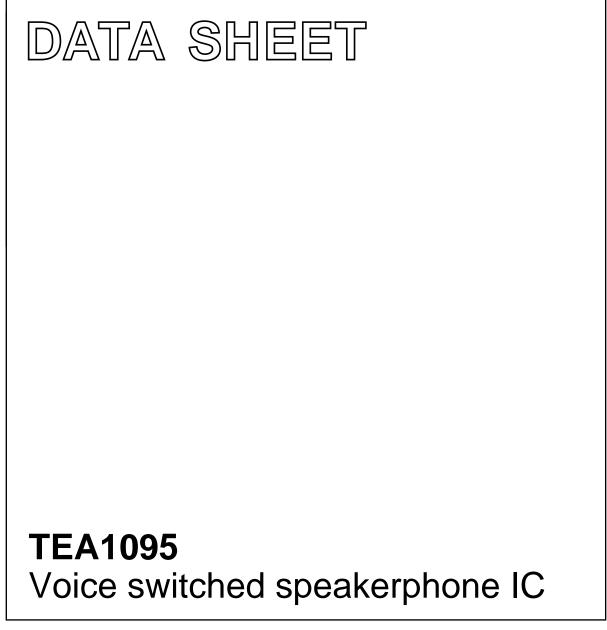
INTEGRATED CIRCUITS



Product specification Supersedes data of 1996 Mar 22 File under Integrated Circuits, IC03 1997 Nov 25



Semiconductors

Philips

TEA1095

FEATURES

- External power supply with power-down function
- Transmit channel with:
 - externally adjustable gain
 - transmit mute function
- · Receive channel with:
 - externally adjustable gain
 - logarithmic volume control via a linear potentiometer
 - receive mute function
- Duplex controller consisting of:
 - signal envelope and noise envelope monitors for both channels with:
 - externally adjustable sensitivity

externally adjustable signal envelope time constant externally adjustable noise envelope time constant

decision logic with:

externally adjustable switch-over timing externally adjustable idle mode timing externally adjustable dial tone detector in receive channel

 voice switch control with: adjustable switching range

constant sum of gain during switching

constant sum of gain at different volume settings.

APPLICATIONS

- · Mains, battery or line-powered telephone sets
- Cordless telephones
- Answering machines
- Fax machines
- · Hands-free car kits.

GENERAL DESCRIPTION

The TEA1095 is a bipolar circuit, that in conjunction with a member of the TEA106X, TEA111X families of transmission or TEA1096 transmission/listening-in circuits offers a hands-free function. It incorporates a transmit amplifier, a receiver channel amplifier and a duplex controller with signal and noise monitors on both channels.

ORDERING INFORMATION

TYPE	PACKAGE		
NUMBER	NAME	NAME DESCRIPTION VE	
TEA1095	DIP24	plastic dual in-line package; 24 leads (600 mil)	SOT101-1
TEA1095T	SO24	SO24 plastic small outline package; 24 leads; body width 7.5 mm SOT	
TEA1095TS	SSOP24	plastic shrink small outline package; 24 leads; body width 5.3 mm	SOT340-1

TEA1095

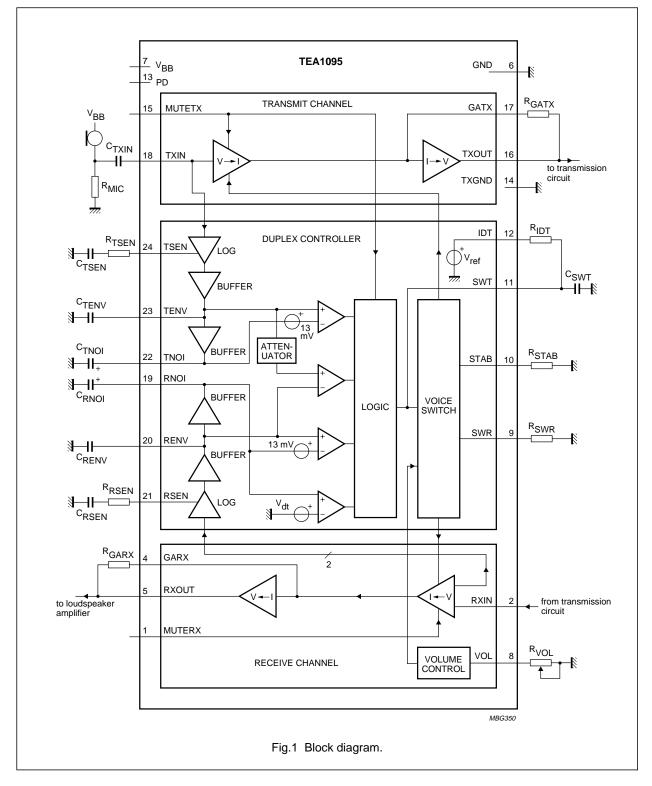
QUICK REFERENCE DATA

 V_{BB} = 5 V; V_{GND} = 0 V; f = 1 kHz; T_{amb} = 25 °C; MUTETX = LOW; MUTERX = LOW; PD = LOW; R_{VOL} = 0 Ω ; measured in test circuit of Fig.11; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{BB}	supply voltage		2.9	-	12.0	V
I _{BB}	current consumption from pin V_{BB}		-	2.7	3.8	mA
G _{vtx}	voltage gain from TXIN to TXOUT in transmit mode	$V_{TXIN} = 1 \text{ mV (RMS)};$ $R_{GATX} = 30.1 \text{ k}\Omega$	-	15.5	-	dB
ΔG_{vtxr}	voltage gain adjustment with R _{GATX}		-15.5	-	+24.5	dB
G _{vrx}	voltage gain from RXIN to RXOUT in receive mode	V_{RXIN} = 20 mV (RMS); R _{GARX} = 16.5 k Ω	-	6.5	-	dB
ΔG_{vrxr}	voltage gain adjustment with R _{GARX}		-20.5	-	+19.5	dB
SWRA	switching range		-	40	-	dB
∆SWRA	switching range adjustment	with R_{SWR} referenced to R_{SWR} = 365 k Ω	-40	-	+12	dB
T _{amb}	operating ambient temperature		-25	-	+75	°C

TEA1095

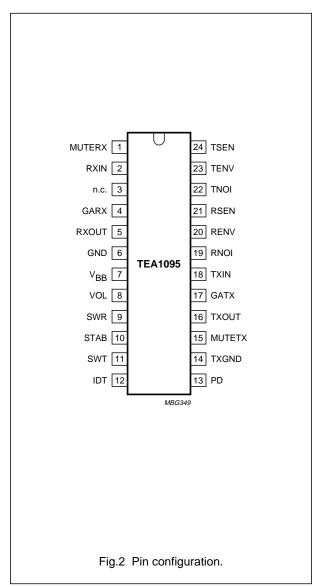
BLOCK DIAGRAM



TEA1095

PINNING

SYMBOL	PIN	DESCRIPTION
MUTERX	1	receiver channel mute input
RXIN	2	receiver amplifier input
n.c.	3	not connected
GARX	4	receiver gain adjustment
RXOUT	5	receiver amplifier output
GND	6	ground reference
V_{BB}	7	supply voltage input
VOL	8	receiver volume adjustment
SWR	9	switching range adjustment
STAB	10	reference current adjustment
SWT	11	switch-over timing adjustment
IDT	12	idle mode timing adjustment
PD	13	power-down input
TXGND	14	ground reference for the transmit channel
MUTETX	15	transmit channel mute input
TXOUT	16	transmit amplifier output
GATX	17	transmit gain adjustment
TXIN	18	transmit amplifier input
RNOI	19	receive noise envelope timing adjustment
RENV	20	receive signal envelope timing adjustment
RSEN	21	receive signal envelope sensitivity adjustment
TNOI	22	transmit noise envelope timing adjustment
TENV	23	transmit signal envelope timing adjustment
TSEN	24	transmit signal envelope sensitivity adjustment



TEA1095

FUNCTIONAL DESCRIPTION

The values given in the functional description are typical values except when otherwise specified.

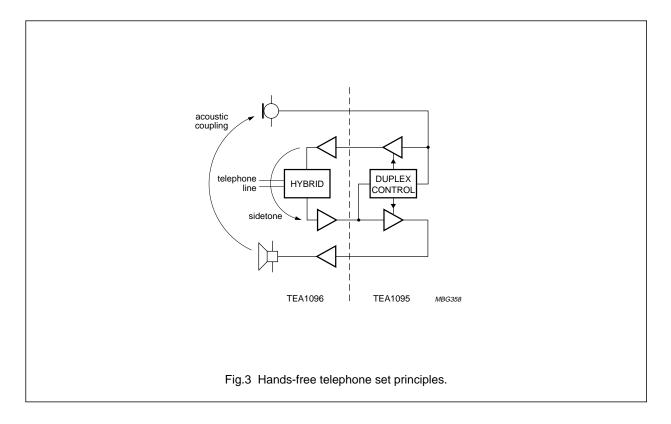
A principle diagram of the TEA1096 is shown on the left side of Fig.3. The TEA1096 is a transmission and listening-in circuit. It incorporates a receiving amplifier for the earpiece, a transmit amplifier for the microphone, a loudspeaker amplifier and a hybrid. For more details on the TEA1096 circuit (please refer to *Data Handbook IC03*). The right side of Fig.3 shows a principle diagram of the TEA1095, a hands-free add-on circuit with a transmit amplifier, a receiver amplifier and a duplex controller.

As can be seen from Fig.3, a loop is formed via the sidetone network in the transmission circuit and the acoustic coupling between loudspeaker and microphone of the hands-free circuit. When this loop gain is greater than 1, howling is introduced. In a full duplex application, this would be the case. The loop-gain has to be much

lower than 1 and therefore has to be decreased to avoid howling. This is achieved by the duplex controller. The duplex controller of the TEA1095 detects which channel has the 'largest' signal and then controls the gains of the transmit amplifier and the receiver amplifier such that the sum of the gains remains constant. As a result, the circuit can be in three stable modes:

- Transmit mode (Tx mode): the gain of the transmit amplifier is at its maximum and the gain of the receiver amplifier is at its minimum.
- Receive mode (Rx mode): the gain of the receiver amplifier is at its maximum and the gain of the transmit amplifier is at its minimum.
- 3. Idle mode: the gain of the amplifiers is halfway between their maximum and minimum value.

The difference between the maximum gain and minimum gain is called the switching range.



TEA1095

Supply: pins V_{BB}, GND and PD

The TEA1095 must be supplied with an external stabilized voltage source between pins V_{BB} and GND. In idle mode, without any signal, the internal supply current is 2.7 mA at V_{BB} = 5 V.

To reduce current consumption during pulse dialling or register recall (flash), the TEA1095 is provided with a power-down (PD) input. When the voltage on PD is HIGH, the current consumption from V_{BB} is 140 μ A.

Transmit channel: pins TXIN, GATX, TXOUT, TXGND and MUTETX

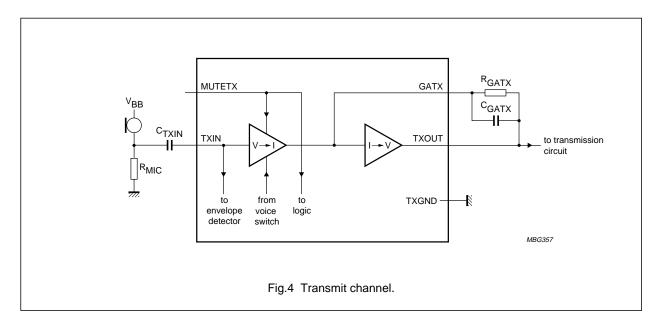
The TEA1095 has an asymmetrical transmit input (TXIN) with an input resistance of 20 k Ω . The gain of the input stage varies according to the mode of the TEA1095. In the transmit mode, the gain is at its maximum; in the receive

mode, it is at its minimum and in the idle mode, it is halfway between maximum and minimum. Switch-over from one mode to the other is smooth and click-free. The output capability at pin TXOUT is 20 μ A (RMS).

In the transmit mode, the overall gain of the transmit amplifier (from pin TXIN to TXOUT) can be adjusted from 0 dB to 40 dB to suit application specific requirements. The gain is proportional to the value of R_{GATX} and equals 15.5 dB with R_{GATX} = 30.1 k Ω .

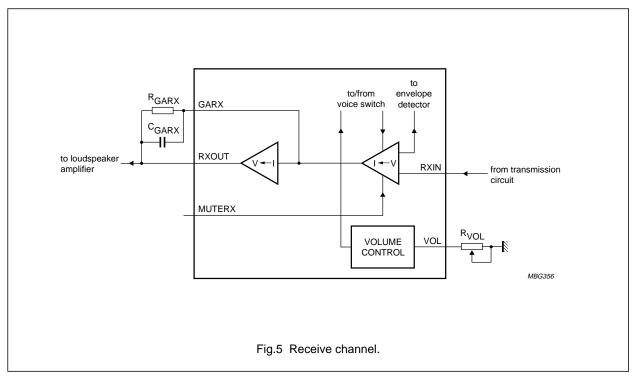
A capacitor must be connected in parallel with R_{GATX} to ensure stability of the transmit amplifier. Together with R_{GATX} , it also provides a first-order low-pass filter.

By applying a HIGH level on pin MUTETX, the transmit amplifier is muted and the TEA1095 is automatically forced into the receive mode.



Voice switched speakerphone IC

Receive channel



RECEIVER AMPLIFIER: PINS RXIN, GARX, RXOUT AND MUTERX

The TEA1095 has an asymmetrical input (RXIN) for the receiver amplifier with an input resistance of 20 k Ω . The gain of the input stage varies according to the mode of the TEA1095. In the receive mode, the gain is at its maximum; in the transmit mode, it is at its minimum and in the idle mode, it is halfway between maximum and minimum. Switch-over from one mode to the other is smooth and click-free.

In the receive mode, the overall gain of the receive amplifier can be adjusted from –14 dB to +26 dB to suit application specific requirements. The gain from RXIN to RXOUT is proportional to the value of R_{GARX} and equals 6.5 dB with R_{GARX} = 16.5 k Ω . A capacitor connected in parallel with R_{GARX} can be used to provide a first-order low-pass filter.

By applying a HIGH level on pin MUTERX, the receiver amplifier is muted and the TEA1095 is automatically forced into the transmit mode.

VOLUME CONTROL: PIN VOL

The receiver amplifier gain can be adjusted with the potentiometer R_{VOL} . A linear potentiometer can be used to obtain logarithmic control of the gain of the receiver amplifier. Each 950 Ω increase of R_{VOL} results in a gain loss of 3 dB. The maximum gain reduction with the volume control is internally limited to the switching range.

Duplex controller

SIGNAL AND NOISE ENVELOPE DETECTORS: PINS TSEN, TENV, TNOI, RSEN, RENV AND RNOI

The signal envelopes are used to monitor the signal level strength in both channels. The noise envelopes are used to monitor background noise in both channels. The signal and noise envelopes provide inputs for the decision logic. The signal and noise envelopes detectors are shown in Fig.6.

For the transmit channel, the input signal at TXIN is 40 dB amplified to TSEN. For the receive channel, the input signal at RXIN is 0 dB amplified to RSEN. The signals from TSEN and RSEN are logarithmically compressed and buffered to TENV and RENV respectively. The sensitivity of the envelope detectors is set with R_{TSEN} and R_{RSEN}.

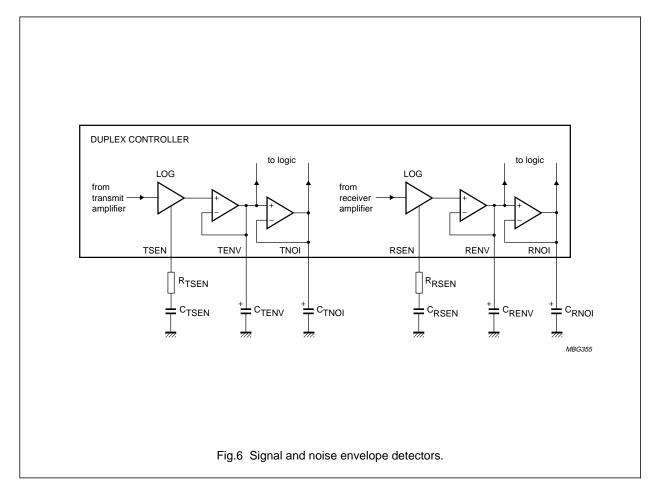
Voice switched speakerphone IC

The capacitors connected in series with the two resistors block any DC component and form a first order high-pass filter. In the basic application (see Fig.12), it is assumed that $V_{TXIN} = 1 \text{ mV}$ (RMS) and $V_{RXIN} = 100 \text{ mV}$ (RMS) nominal and both R_{TSEN} and R_{RSEN} have a value of 10 k Ω . With the value of C_{TSEN} and C_{RSEN} at 100 nF, the cut-off frequency is at 160 Hz.

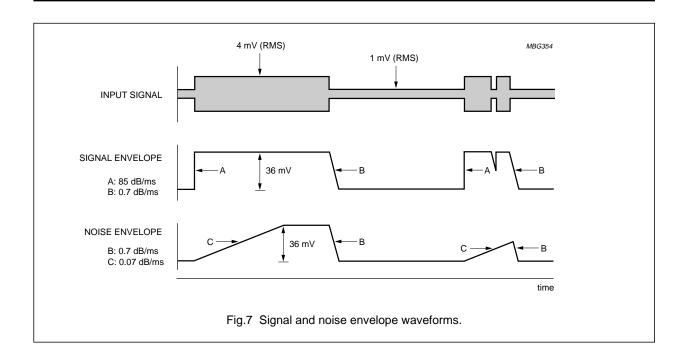
The buffer amplifiers leading the compressed signals to TENV and RENV have a maximum source current of 120 μ A and a maximum sink current of 1 μ A. Together with the capacitors C_{TENV} and C_{RENV}, the timing of the signal envelope monitors can be set. In the basic application, the value of both capacitors is 470 nF. Because of the logarithmic compression, each 6 dB signal increase means 18 mV increase of the voltage on the envelopes TENV or RENV at room temperature. Thus, timings can be expressed in dB/ms. At room temperature, the 120 μ A sourced current corresponds to a maximum rise-slope of the signal envelope of 85 dB/ms. This is enough to track normal speech signals. The 1 μ A current sunk by TENV or

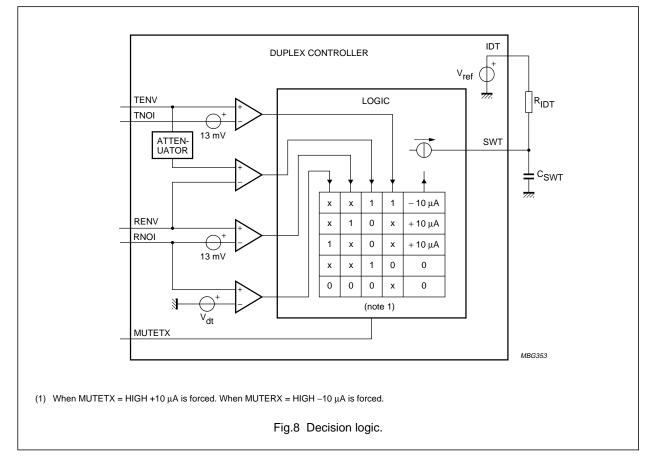
RENV corresponds to a maximum fall-slope of 0.7 dB/ms. This is enough for a smooth envelope and also eliminates the effect of echoes on switching behaviour.

To determine the noise level, the signal on TENV and RENV are buffered to TNOI and RNOI. These buffers have a maximum source current of 1 μ A and a maximum sink current of 120 μ A. Together with the capacitors C_{TNOI} and C_{RNOI}, the timing can be set. In the basic application of Fig.12, the value of both capacitors is 4.7 µF. At room temperature, the 1 µA sourced current corresponds to a maximum rise-slope of the noise envelope of approximately 0.07 dB/ms. This is small enough to track background noise and not to be influenced by speech bursts. The 120 µA current that is sunk corresponds to a maximum fall-slope of approximately 8.5 dB/ms. However, during the decrease of the signal envelope, the noise envelope tracks the signal envelope so it will never fall faster than approximately 0.7 dB/ms. The behaviour of the signal envelope and noise envelope monitors is illustrated in Fig.7.



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DECISION LOGIC: PINS IDT AND SWT

The TEA1095 selects its mode of operation (transmit, receive or idle mode) by comparing the signal and the noise envelopes of both channels. This is executed by the decision logic. The resulting voltage on pin SWT is the input for the voice-switch.

To facilitate the distinction between signal and noise, the signal is considered as speech when its envelope is more than 4.3 dB above the noise envelope. At room temperature, this is equal to a voltage difference $V_{ENV-NOI} = 13 \text{ mV}$. This so called speech/noise threshold is implemented in both channels.

The signal on TXIN contains both speech and the signal coming from the loudspeaker (acoustic coupling). When receiving, the contribution from the loudspeaker overrules the speech. As a result, the signal envelope on TENV is formed mainly by the loudspeaker signal. To correct this, an attenuator is connected between TENV and the TENV/RENV comparator. Its attenuation equals that applied to the transmit amplifier.

When a dial tone is present on the line, without monitoring, the tone would be recognized as noise because it is a signal with a constant amplitude. This would cause the TEA1095 to go into the idle mode and the user of the set would hear the dial tone fade away. To prevent this, a dial tone detector is incorporated which, in standard application, does not consider the input signals at RXIN as noise when they have a level greater than 42 mV (RMS). This level is proportional to R_{RSEN}.

As can be seen from Fig.8, the output of the decision logic is a current source. The logic table gives the relationship between the inputs and the value of the current source. It can charge or discharge the capacitor C_{SWT} with a current of 10 μA (switch-over). If the current is zero, the voltage on SWT becomes equal to the voltage on IDT via the high ohmic resistor R_{IDT} (idling). The resulting voltage difference between SWT and IDT determines the mode of the TEA1095 and can vary between -400 mV and +400 mV.

Table 1 Modes of TEA109

V _{SWT} – V _{IDT} (mV)	MODE
<-180	transmit mode
0	idle mode
>180	receive mode

The switch-over timing can be set with C_{SWT} , the idle mode timing with C_{SWT} and R_{IDT} . In the basic application given in Fig.12, C_{SWT} is chosen at 220 nF and R_{IDT} at 2.2 M Ω . This enables a switch-over time from transmit to receive mode or vice-versa of approximately 13 ms (580 mV swing on SWT). The switch-over time from idle mode to transmit mode or receive mode is approximately 4 ms (180 mV swing on SWT).

The switch-over time from receive mode or transmit mode to idle mode is equal to $4 \times R_{IDT} C_{SWT}$ and is approximately 2 s (idle mode time).

The inputs MUTETX and MUTERX overrule the decision logic. When MUTETX goes HIGH, the capacitor C_{SWT} is charged with 10 μA resulting in the receive mode. When the voltage on pin MUTERX goes HIGH, the capacitor C_{SWT} is discharged with 10 μA resulting in the transmit mode.

VOICE-SWITCH: PINS STAB AND SWR

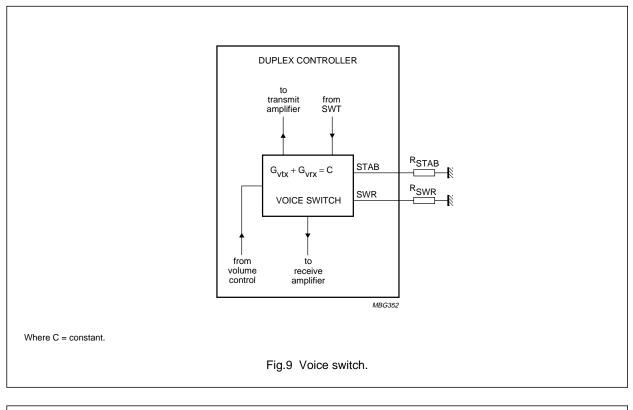
A diagram of the voice-switch is illustrated in Fig.9. With the voltage on SWT, the TEA1095 voice-switch regulates the gains of the transmit and the receive channel such that the sum of both is kept constant.

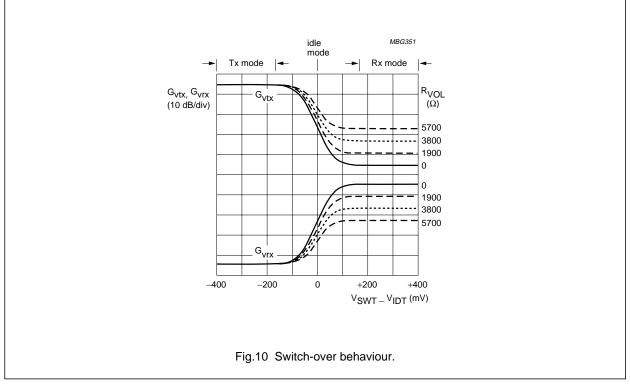
In the transmit mode, the gain of the transmit amplifier is at its maximum and the gain of the receive amplifier is at its minimum. In the receive mode, the opposite applies. In the idle mode, both transmit and receive amplifier gains are halfway.

The difference between maximum and minimum is the so called switching range. This range is determined by the ratio of R_{SWR} and R_{STAB} and is adjustable between 0 and 52 dB. R_{STAB} should be equal to 3.65 k Ω and sets an internally used reference current. In the basic application diagram given in Fig.12, R_{SWR} is equal to 365 k Ω which results in a switching range of 40 dB. The switch-over behaviour is illustrated in Fig.10.

In the receive mode, the gain of the receive amplifier can be reduced using the volume control. Since the voice-switch keeps the sum of the gains constant, the gain of the transmit amplifier is increased at the same time (see dashed curves in Fig.10). In the transmit mode however, the volume control has no influence on the gain of the transmit amplifier or the gain of the receive amplifier. Consequently, the switching range is reduced when the volume is reduced. At maximum reduction of volume, the switching range becomes 0 dB.

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LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{n(max)}	maximum voltage on all pins; except pins V_{BB} and RXIN		V _{GND} – 0.4	V _{BB} + 0.4	V
V _{RIN(max)}	maximum voltage on pin RXIN		V _{GND} – 1.2	V _{BB} + 0.4	V
V _{BB(max)}	maximum voltage on pin V_{BB}		$V_{GND} - 0.4$	12.0	V
T _{stg}	IC storage temperature		-40	+125	°C
T _{amb}	operating ambient temperature		-25	+75	°C

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	VALUE	UNIT
R _{th j-a}	thermal resistance from junction to ambient in free air		
	TEA1095 50 ł		K/W
	TEA1095T 75 K/W		K/W
	TEA1095TS	104	K/W

CHARACTERISTICS

 V_{BB} = 5 V; V_{GND} = 0 V; f = 1 kHz; T_{amb} = 25 °C; MUTETX = LOW; MUTERX = LOW; PD = LOW; R_{VOL} = 0 Ω ; measured in test circuit of Fig.11; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Supply (V _{BE}	, PD and GND)		1			
V _{BB}	supply voltage		2.9	-	12.0	V
I _{BB}	current consumption from pin V_{BB}		-	2.7	3.8	mA
Power-dow	N INPUT PD					
V _{IL}	LOW level input voltage		V _{GND} – 0.4	-	0.3	V
V _{IH}	HIGH level input voltage		1.5	-	V _{BB} + 0.4	V
I _{PD}	power-down input current	PD = HIGH	-	2.5	5	μA
I _{BB(PD)}	current consumption from pin $V_{\mbox{\scriptsize BB}}$ in power-down mode	PD = HIGH	-	140	190	μA
Transmit ch	annel (TXIN, GATX, TXOUT, MUTE	TX and TXGND)	•			
TRANSMIT AN	IPLIFIER					
Z _i	input impedance between pins TXIN and TXGND		17	20	23	kΩ
G _{vtx}	voltage gain from TXIN to TXOUT in transmit mode	$V_{TXIN} = 1 \text{ mV} (RMS);$ $R_{GATX} = 30.1 \text{ k}\Omega$	-	15.5	-	dB
ΔG_{vtxr}	voltage gain adjustment with R _{GATX}		-15.5	-	+24.5	dB
ΔG_{vtxT}	voltage gain variation with temperature referenced to 25 °C	$V_{TXIN} = 1 \text{ mV} (RMS);$ $T_{amb} = -25 \text{ to } +75 ^{\circ}\text{C}$	-	±0.3	-	dB

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SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
ΔG_{vtxf}	voltage gain variation with frequency referenced to 1 kHz	V _{TXIN} = 1 mV (RMS); f = 300 to 3400 Hz	-	±0.3	-	dB
V _{notx}	noise output voltage at pin TXOUT	pin TXIN connected to TXGND through 200 Ω in series with 10 μ F; psophometrically weighted (P53 curve)	-	-100	-	dBmp
TRANSMIT MU	UTE INPUT MUTETX					
V _{IL}	LOW level input voltage		$V_{GND} - 0.4$	-	0.3	V
V _{IH}	HIGH level input voltage		1.5	-	V _{BB} + 0.4	V
I _{MUTETX}	input current	MUTETX = HIGH	-	2.5	5	μA
ΔG_{vtxm}	voltage gain reduction with MUTETX active	MUTETX = HIGH	-	80	-	dB
Receive cha	annel (RXIN, GARX, RXOUT and M	IUTERX)				
RECEIVE AME	PLIFIER					
Z _i	input impedance between pins RXIN and GND		17	20	23	kΩ
G _{vrx}	voltage gain from RXIN to RXOUT in receive mode	$V_{\text{RXIN}} = 20 \text{ mV (RMS)};$ R _{GARX} = 16.5 kΩ	-	6.5	-	dB
ΔG_{vrxr}	voltage gain adjustment with R _{GARX}		-20.5	-	+19.5	dB
ΔG_{vrxT}	voltage gain variation with temperature referenced to 25 °C	$V_{RXIN} = 20 \text{ mV} (RMS);$ $T_{amb} = -25 \text{ to } +75 \text{ °C}$	-	±0.3	-	dB
ΔG_{vrxf}	voltage gain variation with frequency referenced to 1 kHz	$V_{RXIN} = 20 \text{ mV} (RMS);$ f _i = 300 to 3400 Hz	-	±0.3	-	dB
V _{norx(rms)}	noise output voltage at pin RXOUT (RMS value)	input RXIN short-circuited through 200 Ω in series with 10 μ F; psophometrically weighted (P53 curve)	-	20	-	μV
ΔG_{vrxv}	voltage gain variation referenced to ΔR_{VOL} = 950 Ω	when total attenuation does not exceed the switching range	-	3	-	dB
RECEIVE MU	TE INPUT MUTERX					
V _{IL}	LOW level input voltage		$V_{GND} - 0.4$	-	0.3	V
V _{IH}	HIGH level input voltage		1.5	-	V _{BB} + 0.4	V
I _{MUTERX}	input current	MUTERX = HIGH	-	2.5	5	μA

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SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
ΔG_{vrxm}	gain reduction with MUTERX active	MUTERX = HIGH	-	80	-	dB
Envelope a	nd noise detectors (TSEN, TENV,	TNOI, RSEN, RENV and RN	OI)			
PREAMPLIFIE	RS					
G _{v(TSEN)}	voltage gain from TXIN to TSEN		-	40	-	dB
G _{v(RSEN)}	voltage gain between RXIN to RSEN		-	0	-	dB
Logarithmic	C COMPRESSOR AND SENSITIVITY ADJU	STMENT				
Φdet(TSEN)	sensitivity detection on pin TSEN; voltage change on pin TENV when doubling the current from TSEN	I _{TSEN} = 0.8 to 160 μA	-	18	-	mV
Φdet(RSEN)	sensitivity detection on pin RSEN; voltage change on pin RENV when doubling the current from RSEN	I _{RSEN} = 0.8 to 160 μA	-	18	-	mV
SIGNAL ENVE	ELOPE DETECTORS					
I _{source(ENV)}	maximum current sourced from pin TENV or RENV		-	120	-	μA
I _{sink(ENV)}	maximum current sunk by pin TENV or RENV		0.75	1	1.25	μA
ΔV_{ENV}	voltage difference between pins RENV and TENV	when 10 μA is sourced from both RSEN and TSEN; envelope detectors tracking; note 1	-	±3	-	mV
NOISE ENVEL					1	-
I _{source(NOI)}	maximum current sourced from pins TNOI or RNOI		0.75	1	1.25	μA
I _{sink(NOI)}	maximum current sunk by pins TNOI or RNOI		-	120	-	μA
ΔV _{NOI}	voltage difference between pins RNOI and TNOI	when 2 µA is sourced from both RSEN and TSEN; noise detectors tracking; note 1	_	±3	_	mV
DIAL TONE D	ETECTOR					
V _{RINDT(rms)}	threshold level at pin RXIN (RMS value)		-	42	-	mV

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SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Decision lo	gic (IDT and SWT)	Į			1	
SIGNAL RECO	OGNITION					
$\Delta V_{Srx(th)}$	threshold voltage between pins RENV and RNOI to switch-over from receive to idle mode	V _{RXIN} < V _{RINDT} ; note 2	-	13	-	mV
$\Delta V_{Stx(th)}$	threshold voltage between pins TENV and TNOI to switch-over from transmit to idle mode	note 2	-	13	-	mV
SWITCH-OVE	R					•
I _{source(SWT)}	current sourced from pin SWT when switching to receive mode		7.5	10	12.5	μA
I _{sink(SWT)}	current sunk by pin SWT when switching to transmit mode		7.5	10	12.5	μA
I _{idle(SWT)}	current sourced from pin SWT in idle mode		-	0	-	μA
Voice switc	h (STAB and SWR)		•	-		-
SWRA	switching range		-	40	-	dB
∆SWRA	switching range adjustment	with R_{SWR} referenced to $R_{SWR} = 365 \text{ k}\Omega$	-40	-	+12	dB
$ \Delta G_v $	voltage gain variation from transmit mode to idle mode on both channels		-	20	-	dB
G _{tr}	gain tracking (G _{vtx} + G _{vrx}) during switching, referenced to idle mode		-	±0.5	-	dB

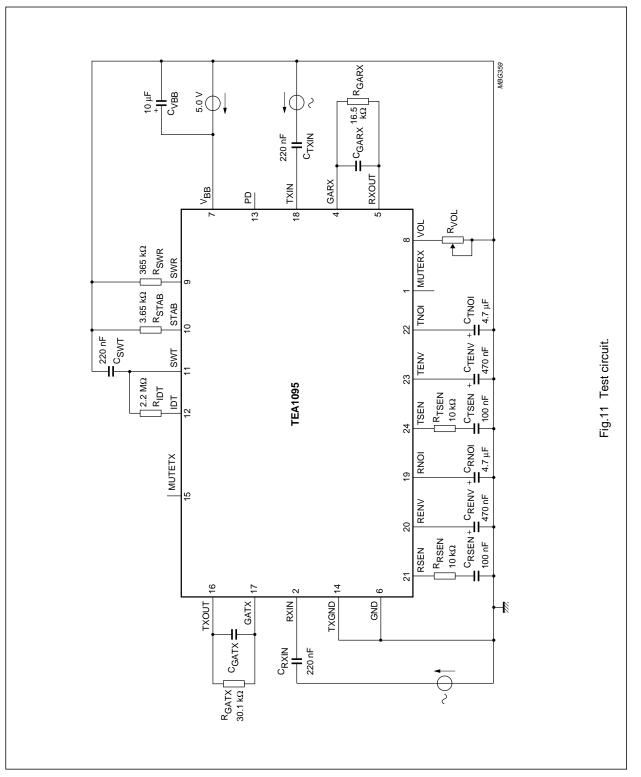
Notes

1. Corresponds to ± 1 dB tracking.

2. Corresponds to 4.3 dB noise/speech recognition level.

Voice switched speakerphone IC

TEST AND APPLICATION INFORMATION





Product specification

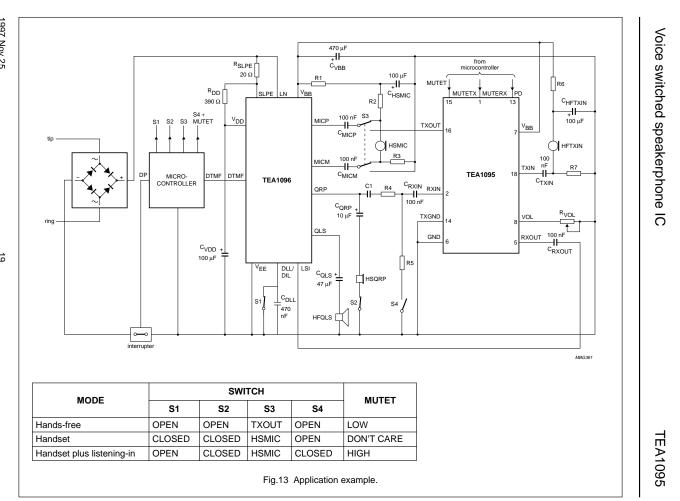
TEA1095

Voice switched speakerphone IC

MBG360 c_{LSP}† LSP RTXIN 2.2 kD LOUDSPEAKER AMPLIFIER C_{TXIN} RGARX 16.5 kΩ 100 nF 100 nF CRXOUT | c_{GARX}† RXOUT GARX TXIN $^{\mathsf{BB}}$ n.c ^RVOL RSWR 365 kΩ 8 c ЧQ SWR CTNOI RSTAB 3.65 kΩ 4.7 µF TNO STAB 22 CTENV 470 nF C_{SWT} TENV SWT 33 Fig.12 Basic application diagram. 10 kΩ TSEN LSEN RIDT 2.2 MΩ SEN **TEA1095** 8 Ы 70 CRNOI MUTERX 4.7 µF RNOI 19 CRENV from microcontroller MUTETX RENV 20 15 RSEN RRSEN 10 kΩ 100 nF 2 CRSEN ლ 17 9 4 CRXIN RXIN 100 nF TXOUT GATX TXGND GND RGATX [≖] [⊥]C_{GATX}∏_F ____30.1 kΩ + C8 100 nF 100 nF 54 MIC -MIC + QR+ R9 20 Ω SLPE Ζ **TEA106X** R1 620Ω Ē vcc CC ⁺C1 100 μF je.



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Product specification

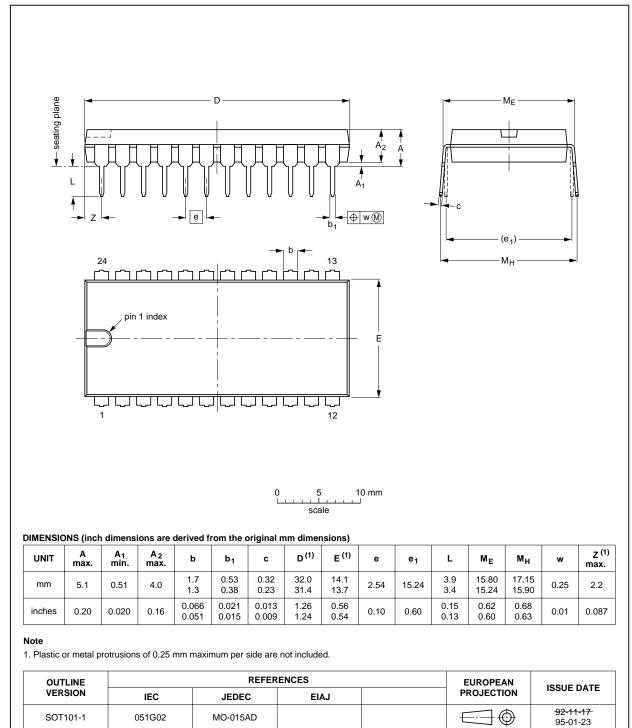
Philips Semiconductors

SOT101-1

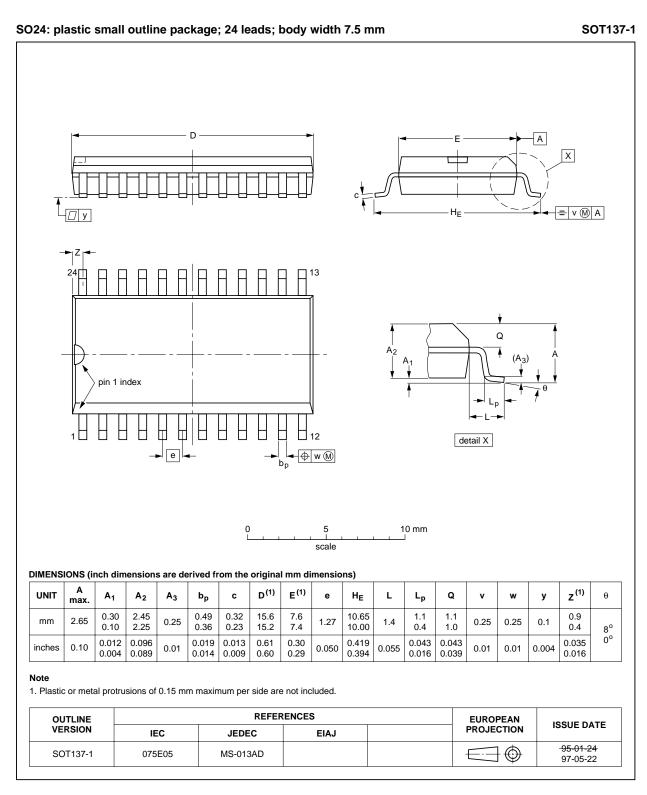
Voice switched speakerphone IC

PACKAGE OUTLINES

DIP24: plastic dual in-line package; 24 leads (600 mil)



Voice switched speakerphone IC



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SSOP24: plastic shrink small outline package; 24 leads; body width 5.3 mm SOT340-1 D Х Η_E = v (M) A Ду 7 13 Q (A₃) pin 1 index Lp IT. detail X - (+ w (M) bp е 5 mm 2.5 0 scale DIMENSIONS (mm are the original dimensions) Α D⁽¹⁾ E⁽¹⁾ Lp Z ⁽¹⁾ UNIT $H_{\rm E}$ L Q θ A₁ A₂ A₃ С е v w bp У max 0.21 1.80 0.38 0.20 8.4 1.03 0.9 0.8 8⁰ 5.4 7.9 1.25 2.0 0.25 0.65 0.2 0.13 0.1 mm 0.05 1.65 0.25 0.09 8.0 5.2 7.6 0.63 0.7 0.4 0° Note 1. Plastic or metal protrusions of 0.20 mm maximum per side are not included. REFERENCES OUTLINE EUROPEAN ISSUE DATE VERSION PROJECTION IEC JEDEC EIAJ 93-09-08 \square SOT340-1 MO-150AG 95-02-04

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SOLDERING

Introduction

There is no soldering method that is ideal for all IC packages. Wave soldering is often preferred when through-hole and surface mounted components are mixed on one printed-circuit board. However, wave soldering is not always suitable for surface mounted ICs, or for printed-circuits with high population densities. In these situations reflow soldering is often used.

This text gives a very brief insight to a complex technology. A more in-depth account of soldering ICs can be found in our "IC Package Databook" (order code 9398 652 90011).

DIP

SOLDERING BY DIPPING OR BY WAVE

The maximum permissible temperature of the solder is 260 °C; solder at this temperature must not be in contact with the joint for more than 5 seconds. The total contact time of successive solder waves must not exceed 5 seconds.

The device may be mounted up to the seating plane, but the temperature of the plastic body must not exceed the specified maximum storage temperature ($T_{stg\,max}$). If the printed-circuit board has been pre-heated, forced cooling may be necessary immediately after soldering to keep the temperature within the permissible limit.

REPAIRING SOLDERED JOINTS

Apply a low voltage soldering iron (less than 24 V) to the lead(s) of the package, below the seating plane or not more than 2 mm above it. If the temperature of the soldering iron bit is less than 300 °C it may remain in contact for up to 10 seconds. If the bit temperature is between 300 and 400 °C, contact may be up to 5 seconds.

SO and SSOP

REFLOW SOLDERING

Reflow soldering techniques are suitable for all SO and SSOP packages.

Reflow soldering requires solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the printed-circuit board by screen printing, stencilling or pressure-syringe dispensing before package placement.

Several techniques exist for reflowing; for example, thermal conduction by heated belt. Dwell times vary between 50 and 300 seconds depending on heating method. Typical reflow temperatures range from 215 to 250 $^{\circ}\text{C}.$

Preheating is necessary to dry the paste and evaporate the binding agent. Preheating duration: 45 minutes at 45 °C.

WAVE SOLDERING

Wave soldering is **not** recommended for SSOP packages. This is because of the likelihood of solder bridging due to closely-spaced leads and the possibility of incomplete solder penetration in multi-lead devices.

If wave soldering cannot be avoided, the following conditions must be observed:

- A double-wave (a turbulent wave with high upward pressure followed by a smooth laminar wave) soldering technique should be used.
- The longitudinal axis of the package footprint must be parallel to the solder flow and must incorporate solder thieves at the downstream end.

Even with these conditions, only consider wave soldering SSOP packages that have a body width of 4.4 mm, that is SSOP16 (SOT369-1) or SSOP20 (SOT266-1).

During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Maximum permissible solder temperature is 260 °C, and maximum duration of package immersion in solder is 10 seconds, if cooled to less than 150 °C within 6 seconds. Typical dwell time is 4 seconds at 250 °C.

A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

REPAIRING SOLDERED JOINTS

Fix the component by first soldering two diagonallyopposite end leads. Use only a low voltage soldering iron (less than 24 V) applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to 300 °C. When using a dedicated tool, all other leads can be soldered in one operation within 2 to 5 seconds between 270 and 320 °C.

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DEFINITIONS

Data sheet status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	
more of the limiting values of the device at these or at	accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or may cause permanent damage to the device. These are stress ratings only and operation any other conditions above those given in the Characteristics sections of the specification limiting values for extended periods may affect device reliability.
Application information	

Where application information is given, it is advisory and does not form part of the specification.

LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.

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